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**Ummethala et al.**

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(54) **PORTION OF A DISPLAY PANEL WITH A GRAPHICAL USER INTERFACE**

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(\*\*) Term: **15 Years**

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(52) **U.S. Cl.**  
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CPC ..... H01L 22/20; H01L 22/12; G06F 3/048; G06F 3/0481; G06F 3/04817; G06F 3/0482; G06F 3/0483; G06F 3/04842; G06F 3/0485; G06F 3/04855; G06F 3/0486; G06F

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(57) **CLAIM**

The ornamental design for a portion of a display panel with a graphical user interface, as shown and described.

**DESCRIPTION**

FIG. 1 is a front view of a portion of a display panel with a graphical user interface showing our new design in a first image.

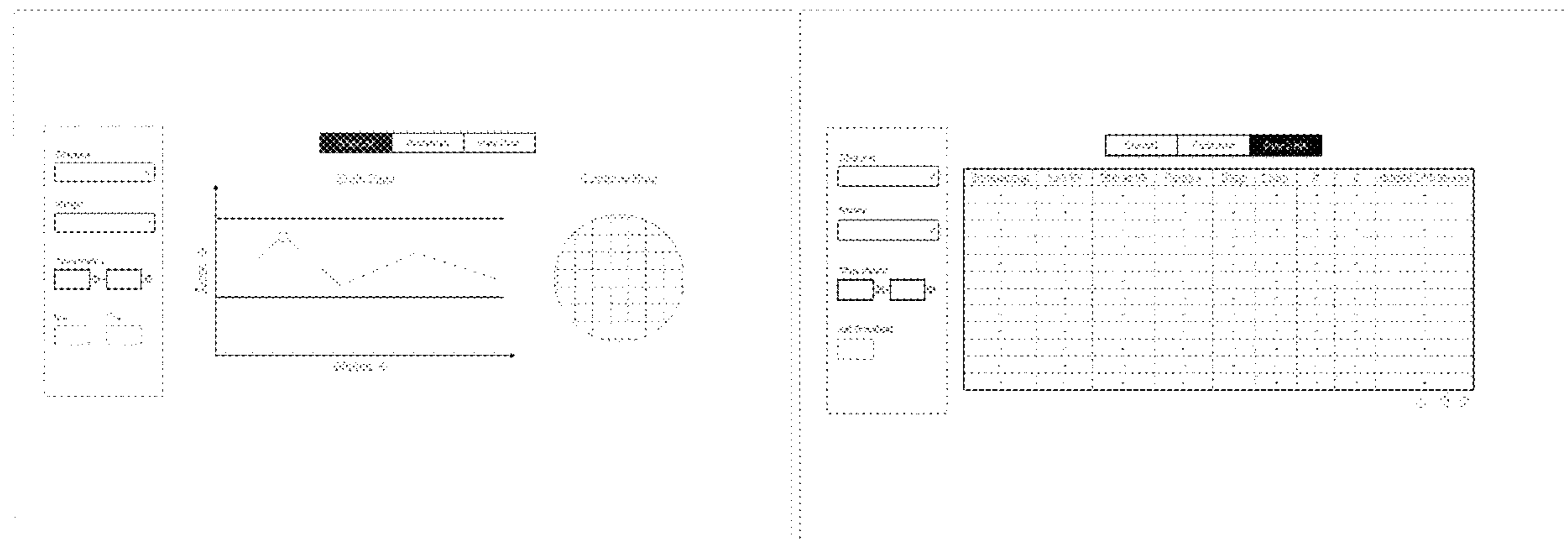
FIG. 2 is a front view of a portion of a display panel with a graphical user interface showing our new design in a second image; and,

FIG. 3 is a front view of a portion of a display panel with a graphical user interface showing our new design in a third image.

The broken lines including the showing of a portion of a display panel with the illustrated graphical user interface and the portions of the graphical user interface are included for the purpose of illustrating environmental structure and form no part of the claimed design.

The appearance of the transitional image sequentially transitions between the images shown in FIGS. 1-3. No ornamental aspects are associated with the process or period in which one image transitions to another image.

**1 Claim, 3 Drawing Sheets**



(58) **Field of Classification Search**

CPC .. 3/0488; G06F 3/04886; G06F 40/103; G06F 40/106; G01B 15/02; G01B 2210/56; G01N 2223/6116; G03F 7/70616; G03F 9/7003

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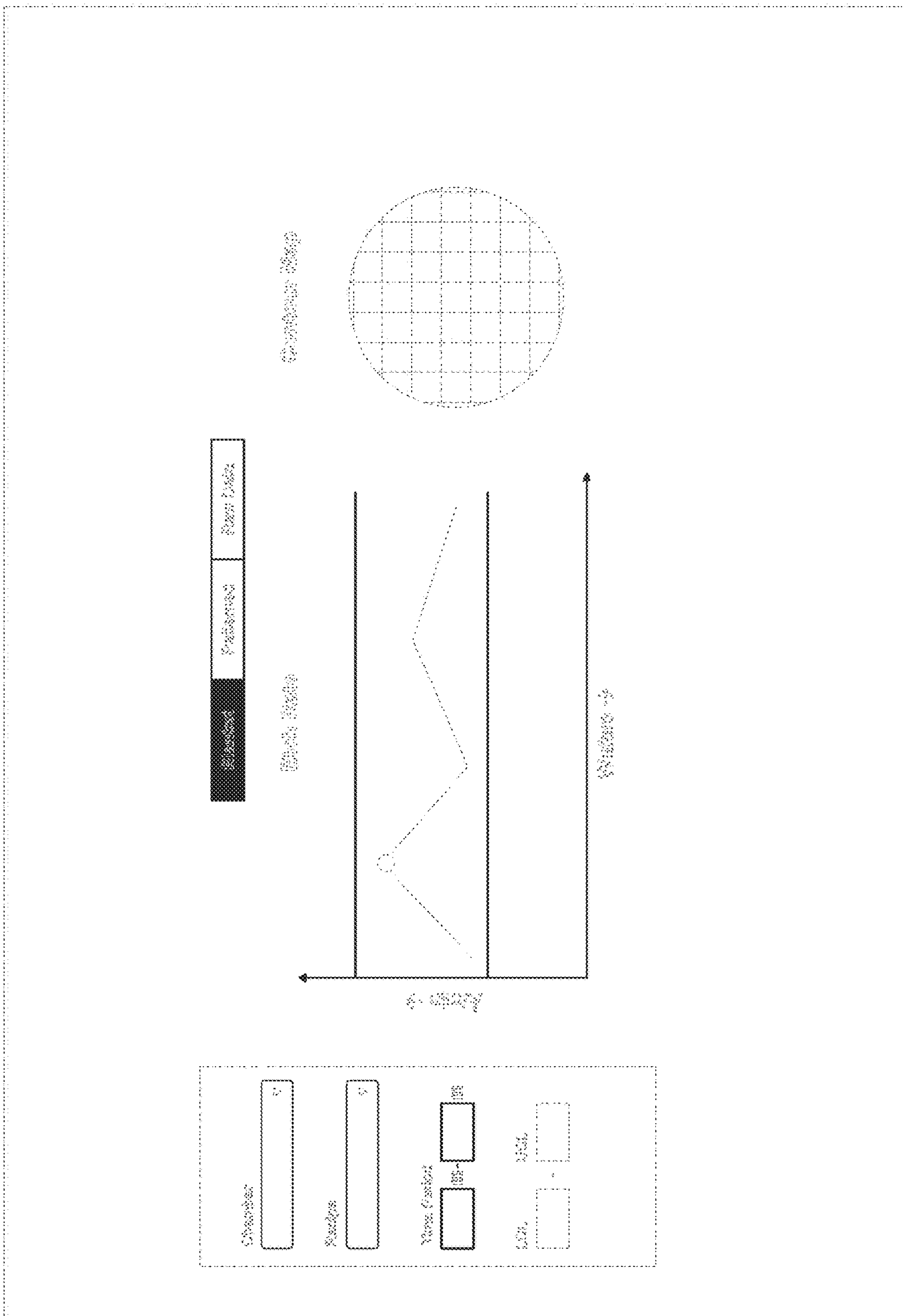


FIG. 1

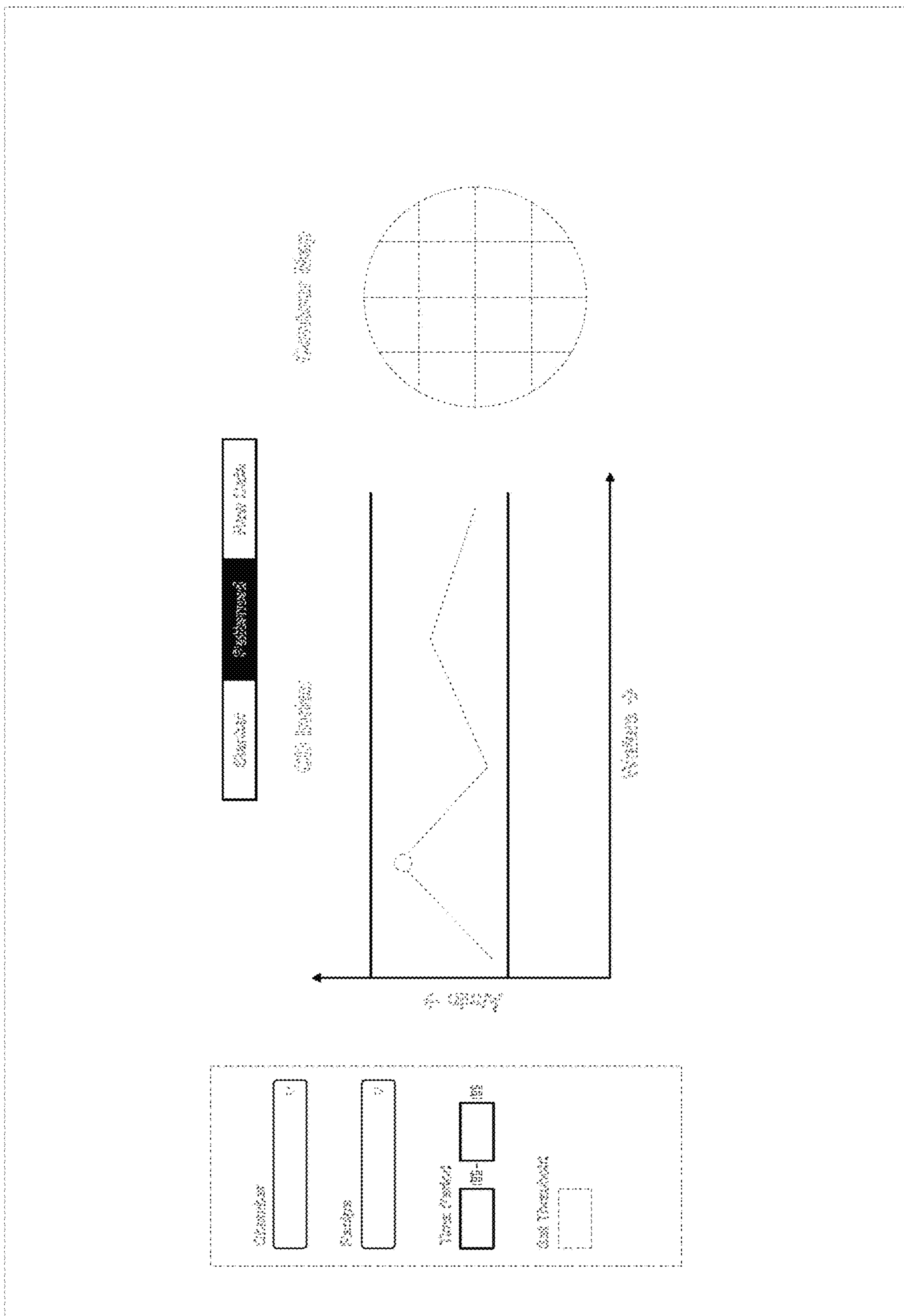


FIG. 2

